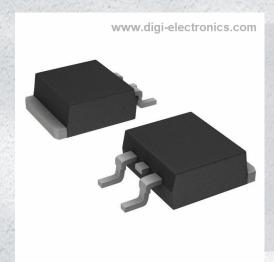


FQB8N60CTM Datasheet



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DiGi Electronics Part Number FQB8N60CTM-DG

Manufacturer onsemi

Manufacturer Product Number FQB8N60CTM

Description MOSFET N-CH 600V 7.5A D2PAK

Detailed Description N-Channel 600 V 7.5A (Tc) 3.13W (Ta), 147W (Tc) Su

rface Mount TO-263 (D2PAK)



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Purchase and inquiry

Manufacturer Product Number:	Manufacturer:
FQB8N60CTM	onsemi
Series:	Product Status:
QFET®	Obsolete
FET Type:	Technology:
N-Channel	MOSFET (Metal Oxide)
Drain to Source Voltage (Vdss):	Current - Continuous Drain (Id) @ 25°C:
600 V	7.5A (Tc)
Drive Voltage (Max Rds On, Min Rds On):	Rds On (Max) @ ld, Vgs:
10V	1.20hm @ 3.75A, 10V
Vgs(th) (Max) @ ld:	Gate Charge (Qg) (Max) @ Vgs:
4V @ 250μA	36 nC @ 10 V
Vgs (Max):	Input Capacitance (Ciss) (Max) @ Vds:
±30V	1255 pF @ 25 V
FET Feature:	Power Dissipation (Max):
	3.13W (Ta), 147W (Tc)
Operating Temperature:	Mounting Type:
-55°C ~ 150°C (TJ)	Surface Mount
Supplier Device Package:	Package / Case:
TO-263 (D2PAK)	TO-263-3, D2PAK (2 Leads + Tab), TO-263AB
Base Product Number:	
FORBN60	

Environmental & Export classification

8541.29.0095

RoHS Status:	Moisture Sensitivity Level (MSL):
ROHS3 Compliant	1 (Unlimited)
REACH Status:	ECCN:
REACH Unaffected	EAR99
HTSUS:	

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ON Semiconductor®

FQB8N60C / FQI8N60C

N-Channel QFET® MOSFET

600 V, 7.5 A, 1.2 Ω

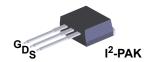
Description

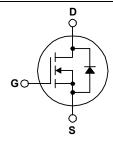
This N-Channel enhancement mode power MOSFET is • Low Gate Charge (Typ. 28 nC) produced using ON Semiconductor's proprietary planar stripe and DMOS technology. This advanced MOSFET technology has been especially tailored to reduce on-state • 100% Avalanche Tested resistance, and to provide superior switching performance and high avalanche energy strength. These devices are suitable for switched mode power supplies, active power factor correction (PFC), and electronic lamp ballasts.

Features

- 7.5 A, 600 V, $R_{DS(on)}$ = 1.2 Ω (Max.) @ V_{GS} = 10 V, $I_D = 3.75 A$
- Low Crss (Typ. 12 pF)
- · RoHS Compliant







Absolute Maximum Ratings T_C = 25°C unless otherwise noted.

Symbol	Parameter		FQB8N60CTM / FQI8N60CTU	Unit
V _{DSS}	Drain-Source Voltage		600	V
I _D	Drain Current - Continuous (T _C = 25°C)		7.5	Α
	- Continuous (T _C = 100°C)		4.6	Α
I _{DM}	Drain Current - Pulsed	(Note 1)	30	Α
V _{GSS}	Gate-Source Voltage		± 30	V
E _{AS}	Single Pulsed Avalanche Energy	(Note 2)	230	mJ
I _{AR}	Avalanche Current	(Note 1)	7.5	Α
E _{AR}	Repetitive Avalanche Energy	(Note 1)	14.7	mJ
dv/dt	Peak Diode Recovery dv/dt	(Note 3)	4.5	V/ns
	Power Dissipation (T _A = 25°C)*		3.13	W
P_D	Power Dissipation (T _C = 25°C)		147	W
	- Derate above 25°C		1.18	W/°C
T_J , T_{STG}	Operating and Storage Temperature Range		-55 to +150	°C
T _L	Maximum Lead Temperature for Soldering, 1/8" from Case for 5 Seconds.		300	°C

Thermal Characteristics

Symbol	Parameter	FQB8N60CTM / FQI8N60CTU	Unit
$R_{\theta JC}$	Thermal Resistance, Junction to Case, Max.	0.85	
В	Thermal Resistance, Junction to Ambient (Minimum Pad of 2-oz Copper), Max.	62.5	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (*1 in ² Pad of 2-oz Copper), Max.	40	1

Package Marking and Ordering Information

Part Number	Top Mark	Package	Packing Method	Reel Size	Tape Width	Quantity
FQB8N60CTM	FQB8N60C	D ² -PAK	Tape and Reel	330 mm	24 mm	800 units
FQI8N60CTU	FQI8N60C	I ² -PAK	Tube	N/A	N/A	50 units

Electrical Characteristics

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
Off Cha	racteristics					
BV _{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	600			V
ΔBV _{DSS} / ΔT _J	Breakdown Voltage Temperature Coefficient	$I_D = 250 \mu A$, Referenced to 25°C		0.7		V/°C
I _{DSS}	7 0 1 1/1 5 1 0 1	V _{DS} = 600 V, V _{GS} = 0 V			1	μΑ
	Zero Gate Voltage Drain Current	V _{DS} = 480 V, T _C = 125°C			10	μΑ
I _{GSSF}	Gate-Body Leakage Current, Forward	V _{GS} = 30 V, V _{DS} = 0 V	-		100	nA
I _{GSSR}	Gate-Body Leakage Current, Reverse	V _{GS} = -30 V, V _{DS} = 0 V			-100	nA

On Characteristics

V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}$, $I_D = 250 \mu A$	2.0		4.0	V
R _{DS(on)}	Static Drain-Source On-Resistance	$V_{GS} = 10 \text{ V}, I_D = 3.75 \text{ A}$		1.0	1.2	Ω
9FS	Forward Transconductance	$V_{DS} = 40 \text{ V}, I_{D} = 3.75 \text{ A}$		8.7		S

Dynamic Characteristics

C _{iss}	Input Capacitance	$V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V},$	 965	1255	pF
Coss	Output Capacitance	f = 1.0 MHz	 105	135	pF
C _{rss}	Reverse Transfer Capacitance		 12	16	pF

Switching Characteristics

t _{d(on)}	Turn-On Delay Time	V _{DD} = 300 V, I _D = 7.5A,	 16.5	45	ns
t _r	Turn-On Rise Time	$R_G = 25 \Omega$	 60.5	130	ns
t _{d(off)}	Turn-Off Delay Time		 81	170	ns
t _f	Turn-Off Fall Time	(Note 4)	 64.5	140	ns
Qg	Total Gate Charge	V _{DS} = 480 V, I _D = 7.5A,	 28	36	nC
Q_{gs}	Gate-Source Charge	V _{GS} = 10 V	 4.5		nC
Q _{gd}	Gate-Drain Charge	(Note 4)	 12		nC

Drain-Source Diode Characteristics and Maximum Ratings

I _S	Maximum Continuous Drain-Source Diode Forward Current		 	7.5	Α
I _{SM}	Maximum Pulsed Drain-Source Diode Forward Current		 	30	Α
V _{SD}	Drain-Source Diode Forward Voltage V _{GS} = 0 V, I _S = 7.5 A		 	1.4	V
t _{rr}	Reverse Recovery Time	$V_{GS} = 0 \text{ V}, I_{S} = 7.5 \text{ A},$	 365		ns
Q _{rr}	Reverse Recovery Charge	$dI_F / dt = 100 A/\mu s$	 3.4		μС

Notes: 1. Repetitive rating: pulse-width limited by maximum junction temperature. 2.L = 7.3 mH, I_{AS} = 7.5 A, V_{DD} = 50 V, R_{G} = 25 Ω , starting T_{J} = 25°C. 3. $I_{SD} \le 7.5$ A, di/dt ≤ 200 A/ μ s , $V_{DD} \le BV_{DSS}$, starting T_{J} = 25°C. 4. Essentially independent of operating temperature.

Typical Characteristics

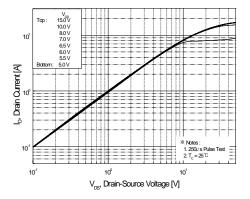


Figure 1. On-Region Characteristics

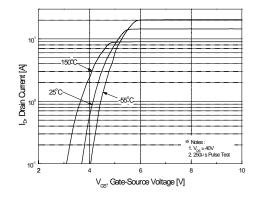


Figure 2. Transfer Characteristics

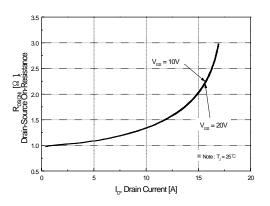


Figure 3. On-Resistance Variation vs Drain Current and Gate Voltage

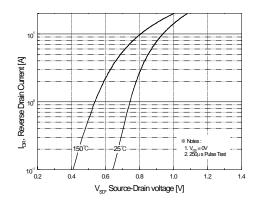


Figure 4. Body Diode Forward Voltage Variation with Source Current and Temperature

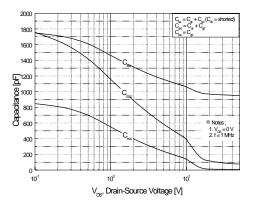


Figure 5. Capacitance Characteristics

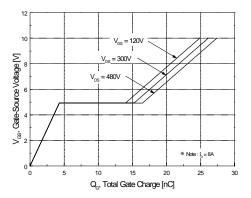
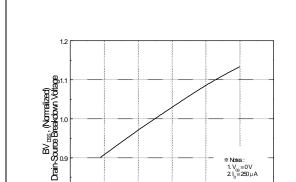


Figure 6. Gate Charge Characteristics



Typical Characteristics (Continued)

Figure 7. Breakdown Voltage Variation vs Temperature

T_,, Junction Temperature [°C]

150

200

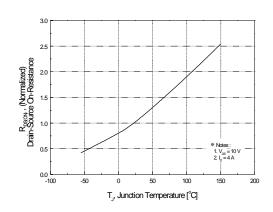


Figure 8. On-Resistance Variation vs Temperature

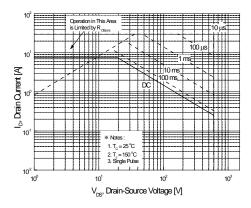


Figure 9. Maximum Safe Operating Area

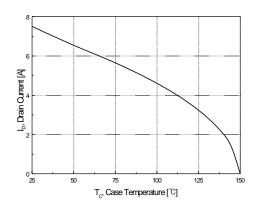


Figure 10. Maximum Drain Current vs Case Temperature

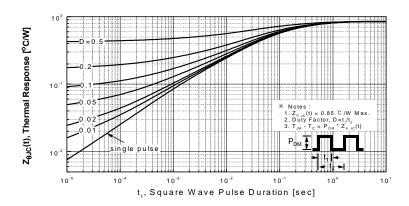


Figure 11. Transient Thermal Response Curve

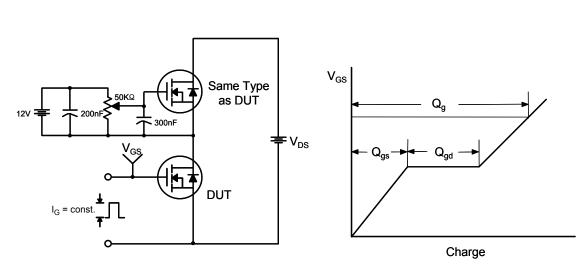


Figure 12. Gate Charge Test Circuit & Waveform

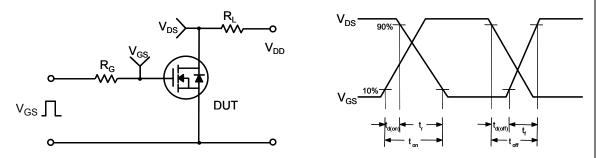


Figure 13. Resistive Switching Test Circuit & Waveforms

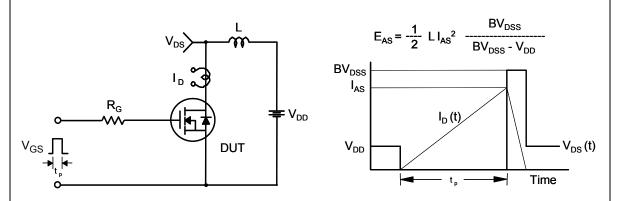
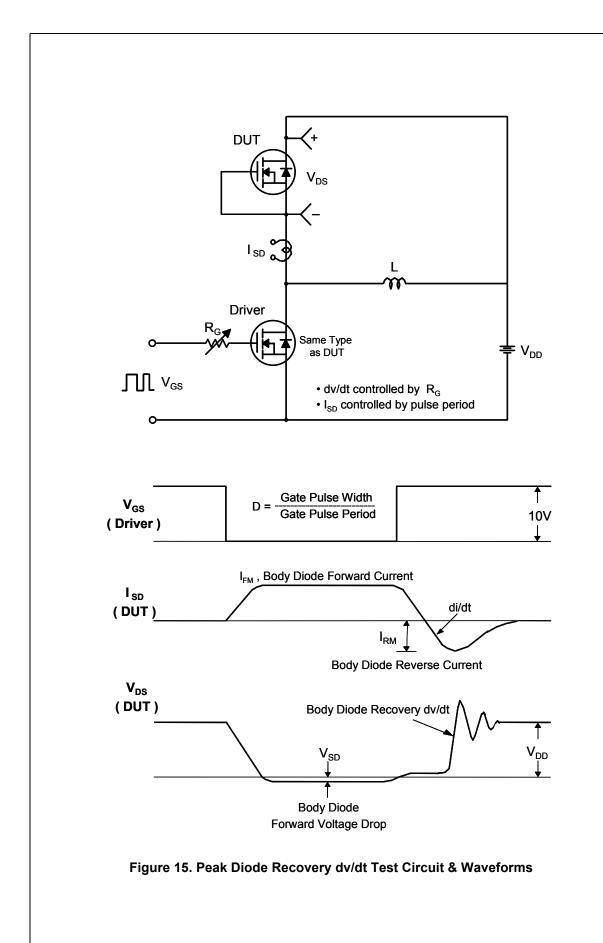


Figure 14. Unclamped Inductive Switching Test Circuit & Waveforms



Mechanical Dimensions

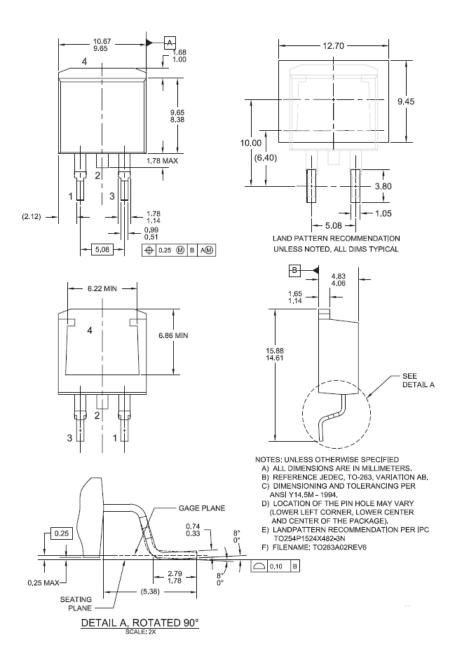
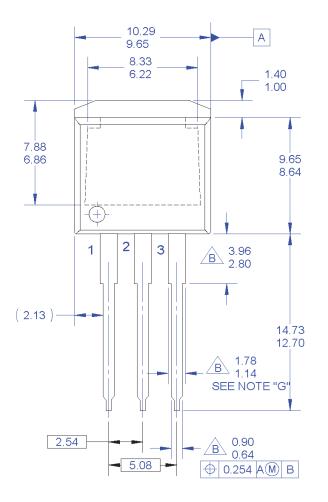
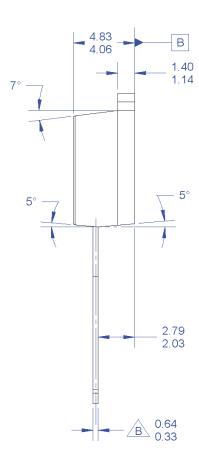


Figure 16. TO263 (D²PAK), Molded, 2-Lead, Surface Mount

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Mechanical Dimensions





NOTES:

- A. EXCEPT WHERE NOTED CONFORMS TO
 T0262 JEDEC VARIATION AA.
 B DOES NOT COMPLY JEDEC STD. VALUE.
 C. ALL DIMENSIONS ARE IN MILLIMETERS.
 D. DIMENSIONS ARE EXCLUSIVE OF BURRS,
 MOLD FLASH AND THE BAR PROTRUSIONS.
- E. DIMENSION AND TOLERANCE AS PER ANSI
- F. LOCATION OF PIN HOLE MAY VARY
 (LOWER LEFT CORNER, LOWER CENTER
 AND CENTER OF PACKAGE)
 G. MAXIMUM WIDTH FOR F102 DEVICE = 1.35 MAX.
 H. DRAWING FILE NAME: TO262A03REV5

Figure 17. TO262 (I²PAK), Molded, 3-Lead, Jedec Variation AA

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